

Notice of References CitedApplication/Control No.
09/726,337Applicant(s)/Patent Under
Reexamination
ZHANG ET AL.Examiner
W. David ColemanArt Unit
2823

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,422,302	06-1995	Yonehara et al.	117/913
	B	US-4,740,829	04-1988	Nakagiri et al.	257/65
	C	US-5,294,560	03-1994	Ono et al.	148/DIG.136
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Borders et al., "Modern Materials Analysis Techniques", October 1986, An MRS Short Course, pp. 62-63
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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